

Single Channel, Ultra-Low Resistance Load Switch

Check for Samples: TPS22965

FEATURES

- **Integrated Single Channel Load Switch**
- Input Voltage Range: 0.8V to 5.5V
- Ultra low Ron Resistance
 - $R_{ON} = 16m\Omega$ at $V_{IN} = 5V$ ($V_{BIAS} = 5V$)
 - $R_{ON} = 16mΩ$ at $V_{IN} = 3.6V$ ($V_{BIAS} = 5V$)
 - R_{ON} = 16mΩ at V_{IN} = 1.8V (V_{BIAS} = 5V)
- **6A Maximum Continuous Switch Current**
- Low Quiescent Current (50µA)
- Low Control Input Threshold Enables Use of 1.2V/1.8V/2.5V/3.3V Logic
- Configurable Rise Time
- **Quick Output Discharge (QOD)**
- **SON 8-pin Package With Thermal Pad**
- **ESD Performance Tested per JESD 22**
 - 2KV HBM and 1KV CDM

APPLICATIONS

- Ultrabook™
- Notebooks/Netbooks
- **Tablet PC**
- **Consumer Electronics**
- **Set-top Boxes/Residental Gateways**
- **Telecom Systems**
- Solid State Drives (SSD)

DESCRIPTION

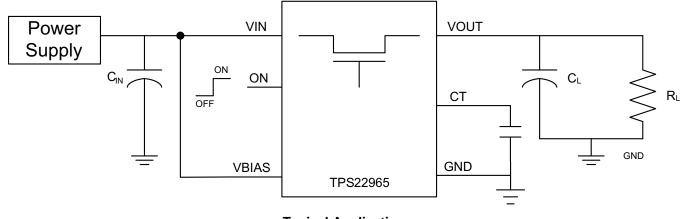
The TPS22965 is a small, ultra-low R_{ON}, single channel load switch with controlled turn on. The device contains an N-channel MOSFET that can operate over an input voltage range of 0.8V to 5.5V and can support a maximum continuous current of 6A. The switch is controlled by an on/off input (ON), which is capable of interfacing directly with lowvoltage control signals. In the TPS22965, a 225-Ω onchip load resistor is added for quick output discharge when switch is turned off.

The TPS22965 is available in a small, space-saving 2mm x 2mm 8-pin SON package (DSG) with integrated thermal pad allowing for high power dissipation. The device is characterized for operation over the free-air temperature range of -40°C to 85°C.

Feature List

R _{ON} Typical at 3.6 V (V _{BIAS} = 5V)	16 mΩ
Rise Time ⁽¹⁾	Adjustable
Quick Output Discharge ⁽²⁾	Yes
Maximum Output Current	6 A
GPIO Enable	Active High
Operating Temperature	-40°C to 85°C

- (1) See Application Information section for CT value vs. rise time.
- (2) This feature discharges the output of the switch to GND through a 225-Ω resistor, preventing the output from floating.



Typical Application

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These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

ABSOLUTE MAXIMUM RATINGS

over operating free-air temperature range (unless otherwise noted) (1)(2)

	-		VALUE	UNIT ⁽²⁾
V _{IN}	Input voltage range		-0.3 to 6	V
V_{OUT}	Output voltage range		-0.3 to 6	V
V_{BIAS}	Bias voltage range		-0.3 to 6	V
V _{ON}	Input voltage range		-0.3 to 6	V
I _{MAX}	Maximum continuous switch	current	6	Α
I _{PLS}	Maximum pulsed switch cur	rent, pulse <300 µs, 2% duty cycle	8	Α
T _A	Operating free-air temperatu	ire range ⁽³⁾	-40 to 85	°C
TJ	Maximum junction temperat	ure	125	°C
T _{STG}	Storage temperature range		-65 to 150	°C
T _{LEAD}	Maximum lead temperature	(10-s soldering time)	300	°C
FCD	Electrostatic discharge	Human-Body Model (HBM)	2000	V
ESD	protection	Charged-Device Model (CDM)	1000	V

⁽¹⁾ Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under recommended operating conditions is not implied. Exposure to absolute—maximum—rated conditions for extended periods may affect device reliability.

(2) All voltage values are with respect to network ground terminal.

THERMAL INFORMATION

	TUEDNAL METRIC(1)	TPS22965	LINUTO
	THERMAL METRIC ⁽¹⁾	DSG (8 PINS)	UNITS
θ_{JA}	Junction-to-ambient thermal resistance	65.3	
θ_{JCtop}	Junction-to-case (top) thermal resistance	74.2	
θ_{JB}	Junction-to-board thermal resistance	35.4	°C/W
ΨЈТ	Junction-to-top characterization parameter	2.2	C/VV
ΨЈВ	Junction-to-board characterization parameter	36.0	
θ_{JCbot}	Junction-to-case (bottom) thermal resistance	12.8	

(1) For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report, SPRA953.

In applications where high power dissipation and/or poor package thermal resistance is present, the maximum ambient temperature may have to be derated. Maximum ambient temperature $[T_{A(max)}]$ is dependent on the maximum operating junction temperature $[T_{J(max)}]$, the maximum power dissipation of the device in the application $[P_{D(max)}]$, and the junction-to-ambient thermal resistance of the part/package in the application (θ_{JA}) , as given by the following equation: $TA_{(max)} = T_{J(max)} - (\theta_{JA} \times P_{D(max)})$



RECOMMENDED OPERATING CONDITIONS

			MIN	MAX	UNIT	
V_{IN}	Input voltage range		0.8	V_{BIAS}	V	
V_{BIAS}	Bias voltage range	Bias voltage range				
V _{ON}	ON voltage range				V	
V _{OUT}	Output voltage range				V	
V _{IH}	High-level input voltage, ON	V _{BIAS} = 2.5 V to 5.5 V	1.2	5.5	V	
V _{IL}	Low-level input voltage, ON	V _{BIAS} = 2.5 V to 5.5 V	0	0.5	V	
C _{IN}	Input capacitor		1 ⁽¹⁾		μF	

⁽¹⁾ Refer to Application Information section.

ELECTRICAL CHARACTERISTICS

Unless otherwise note, the specification in the following table applies over the operating ambient temperature $-40^{\circ}\text{C} \leq T_{A} \leq 85^{\circ}\text{C}$ (Full) and $V_{BIAS} = 5.0 \text{ V}$. Typical values are for $T_{A} = 25^{\circ}\text{C}$.

	PARAMETER	TEST CON	TEST CONDITIONS			MAX	UNIT
POWER SUF	PPLIES AND CURRENTS						
I _{IN(VBIAS-ON)}	V _{BIAS} quiescent current	$I_{OUT} = 0,$ $V_{IN} = V_{ON} = V_{BIAS} = 5.$	0 V	Full	50	75	μA
I _{IN(VBIAS-OFF)}	V _{BIAS} shutdown current	$V_{ON} = GND, V_{OUT} = 0$	V	Full		2	μΑ
,			$V_{IN} = 5.0 \ V$		0.2	8	
	V off state supply surrent	$V_{ON} = GND,$	$V_{IN} = 3.3 \text{ V}$	F	0.02	3	
I _{IN(VIN-OFF)}	V _{IN} off-state supply current	$V_{OUT} = 0 V$	$V_{IN} = 1.8 \text{ V}$	Full	0.01	2	μA
			$V_{IN} = 0.8 \ V$		0.005	1	
I _{ON}	ON pin input leakage current	V _{ON} = 5.5 V		Full		0.5	μΑ
RESISTANC	E CHARACTERISTICS	·					
			V 50V	25°C	16	23	mΩ
			$V_{IN} = 5.0 \text{ V}$	Full		25	11122
			V _{IN} = 3.3 V	25°C	16	23	mΩ
			V _{IN} = 3.3 V	Full		25	11122
			\/ _ 1 9 \/	25°C	16	23	mΩ
D	ON-state resistance	$I_{OUT} = -200 \text{ mA},$	$V_{IN} = 1.8 \text{ V}$	Full		25	11152
R _{ON}	ON-state resistance	$V_{BIAS} = 5.0 \text{ V}$	\/ 1.5.\/	25°C	16	23	mΩ
			$V_{IN} = 1.5 \text{ V}$	Full		25	11122
			V -12V	25°C	16	23	mΩ
			V _{IN} = 1.2 V	Full		25	11122
			V 0.8.V	25°C	16	23	
			$V_{IN} = 0.8 V$	Full		25	mΩ
R _{PD}	Output pulldown resistance	$V_{IN} = 5.0 \text{ V}, V_{ON} = 0 \text{V},$	I _{OUT} = 15 mA	Full	225	300	Ω



ELECTRICAL CHARACTERISTICS

Unless otherwise noted, the specification in the following table applies over the operating ambient temperature $-40^{\circ}\text{C} \leq T_{A} \leq 85^{\circ}\text{C}$ (Full) and $V_{BIAS} = 2.5 \text{ V}$. Typical values are for $T_{A} = 25^{\circ}\text{C}$.

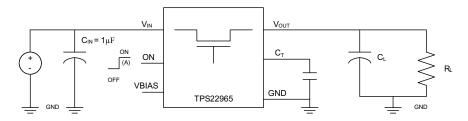
	PARAMETER	TEST COND	TEST CONDITIONS			MAX	UNIT
POWER SUF	PPLIES AND CURRENTS						
I _{IN(VBIAS-ON)}	V _{BIAS} quiescent current	$I_{OUT} = 0,$ $V_{IN} = V_{ON} = V_{BIAS} = 2.5$	5 V	Full	20	30	μΑ
I _{IN(VBIAS-OFF)}	V _{BIAS} shutdown current	$V_{ON} = GND, V_{OUT} = 0$	/	Full		2	μΑ
			$V_{IN} = 2.5 \text{ V}$		0.01	3	
	V off state cumply current	$V_{ON} = GND,$	$V_{IN} = 1.8 \text{ V}$	Full	0.01	2	
I _{IN(VIN-OFF)}	V _{IN} off-state supply current	$V_{OUT} = 0 V$	$V_{IN} = 1.2 \text{ V}$	Full	0.005	2	μA
			V _{IN} = 0.8 V		0.003	1	
I _{ON}	ON pin input leakage current	V _{ON} = 5.5 V		Full		0.5	μΑ
RESISTANC	E CHARACTERISTICS	•					
			V _{IN} = 2.5 V	25°C	20	26	mΩ mΩ mΩ
				Full		28	
			\/ 10\/	25°C	19	26	
			V _{IN} = 1.8 V	Full		28	
D	ON-state resistance	$I_{OUT} = -200 \text{ mA},$	V 45V	25°C	18	25	
R _{ON}	ON-state resistance	$V_{BIAS} = 2.5 \text{ V}$	$V_{IN} = 1.5 V$	Full		27	
			V 40V	25°C	18	25	0
			$V_{IN} = 1.2 V$	Full		27	mΩ
			V 00V	25°C	17	25	mΩ
			$V_{IN} = 0.8 \text{ V}$	Full		27	
R _{PD}	Output pulldown resistance	$V_{IN} = 2.5 \text{ V}, V_{ON} = 0 \text{V},$	I _{OUT} = 1 mA	Full	275	325	Ω

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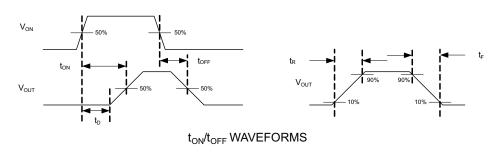
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SWITCHING CHARACTERISTIC MEASUREMENT INFORMATION



TEST CIRCUIT



(A) Rise and fall times of the control signal is 100ns.

Figure 1. Test Circuit and ton/toff Waveforms

SWITCHING CHARACTERISTICS

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	PARAMETER	TEST CONDITION	MIN TYP MA	X UNIT
V _{IN} = \	/ _{ON} = V _{BIAS} = 5 V, T _A = 25	⁰ C (unless otherwise noted)	·	
t _{ON}	Turn-on time		1325	
t _{OFF}	Turn-off time		10	
t _R	V _{OUT} rise time	$R_L = 10-\Omega$, $C_L = 0.1 \mu F$, $C_T = 1000 pF$	1625	μs
t _F	V _{OUT} fall time		3.5	
t _D	ON delay time		500	
$V_{IN} = 0$	0.8 V, $V_{ON} = V_{BIAS} = 5V, T_{A}$	_A = 25°C (unless otherwise noted)		
t _{ON}	Turn-on time		600	
t _{OFF}	Turn-off time		80	
t_R	V _{OUT} rise time	$R_L = 10-\Omega$, $C_L = 0.1 \mu F$, $C_T = 1000 pF$	300	μs
t _F	V _{OUT} fall time		5.5	
t _D	ON delay time		460	
V _{IN} = 2	$2.5V$, $V_{ON} = 5 V$, $V_{BIAS} = 2$.	5V, T _A = 25°C (unless otherwise noted)		
t _{ON}	Turn-on time		2200	
t _{OFF}	Turn-off time		9	
t _R	V _{OUT} rise time	$R_L = 10-\Omega$, $C_L = 0.1 \mu F$, $C_T = 1000 pF$	2275	μs
t _F	V _{OUT} fall time		3.1	
t _D	ON delay time		1075	
$V_{IN} = 0$	$0.8 \text{ V}, \text{ V}_{ON} = 5 \text{ V}, \text{ V}_{BIAS} = 2$.5 V, T _A = 25°C (unless otherwise noted)		
t _{ON}	Turn-on time		1450	
t _{OFF}	Turn-off time		60	
t_R	V _{OUT} rise time	$R_L = 10-\Omega$, $C_L = 0.1 \mu F$, $C_T = 1000 pF$	875	μs
t _F	V _{OUT} fall time		5.5	
t_D	ON delay time		1010	

FUNCTIONAL BLOCK DIAGRAM

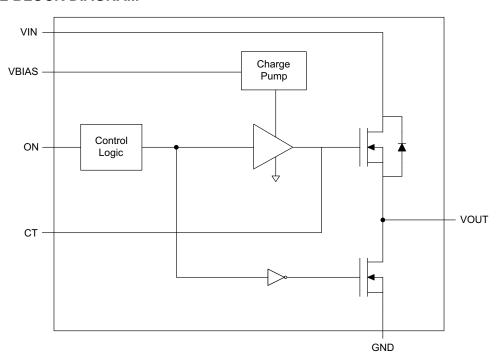
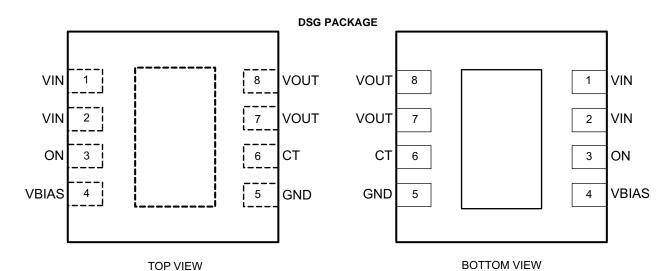


Figure 2. Functional Block Diagram

Table 1. FUNCTIONAL TABLE

ON	VIN to VOUT	VOUT to GND		
L	Off	On		
Н	On	Off		



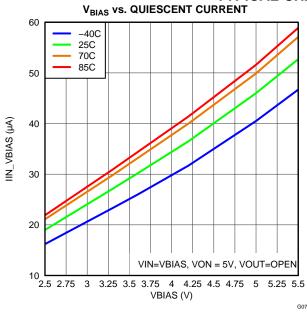


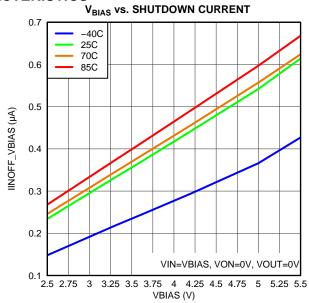
PIN DESCRIPTIONS

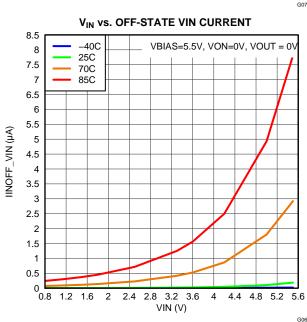
TPS22965	DIN NAME	1/0	DESCRIPTION
DSG	PIN NAME	1/0	DESCRIPTION
1	VIN	I	Switch input. Input bypass capacitor recommended for minimizing V_{IN} dip. Recommended voltage range for this pin for optimal R_{ON} performance is 0.8V to V_{BIAS} .
2	VIN	I	Switch input. Input bypass capacitor recommended for minimizing V_{IN} dip. Recommended voltage range for this pin for optimal R_{ON} performance is 0.8V to V_{BIAS} .
3	ON	I	Active high switch control input. Do not leave floating.
4	VBIAS	I	Bias voltage. Power supply to the device. Recommended voltage range for this pin is 2.5V to 5.5V. See Application Information section for more information.
5	GND	-	Device ground.
6	СТ	0	Switch slew rate control. Can be left floating. See Application Information section for more information.
7	VOUT	0	Switch output.
8	VOUT	0	Switch output.
	Thermal Pad	-	Thermal pad (exposed center pad) to alleviate thermal stress. Tie to GND. See Application Information for layout guidelines.

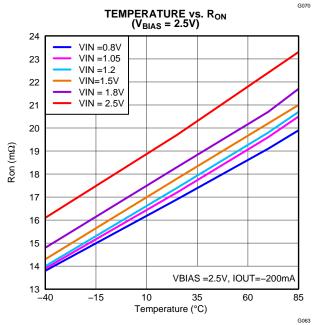


TYPICAL CHARACTERISTICS



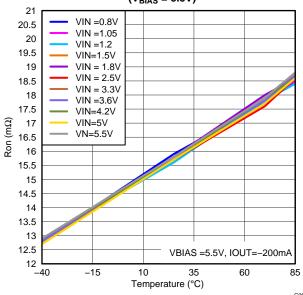


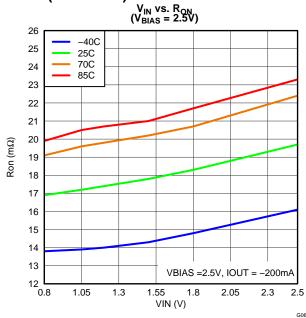


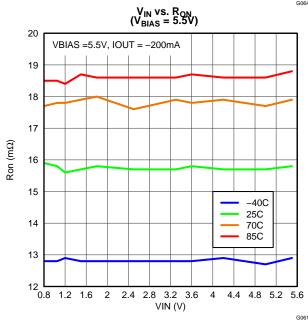


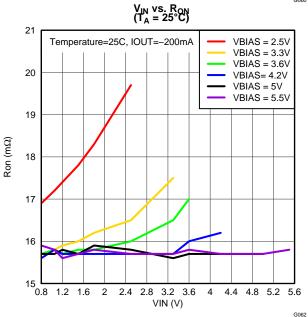












70C

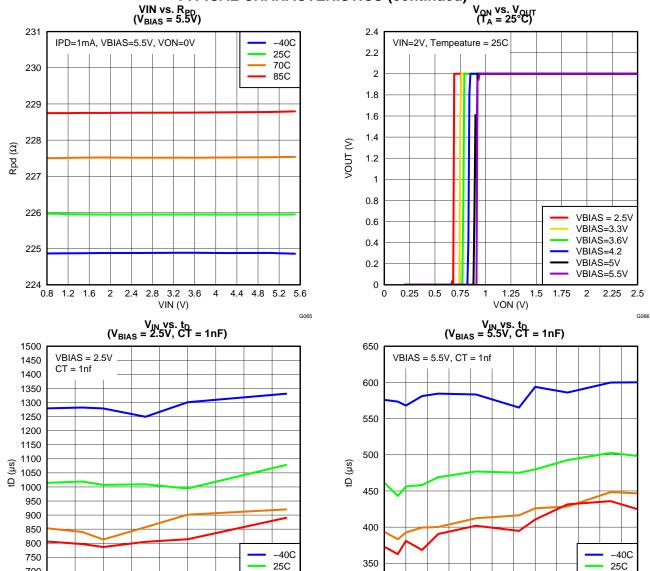
85C

G035

4.4 4.8 5.2 5.5







70C

85C

2.6

G030

2.4

300 -

1.2 1.6

2

1.2

1.4

1.6 1.8

VIN (V)

2

2.2

2.4 2.8 3.2 3.6

VIN (V)

4

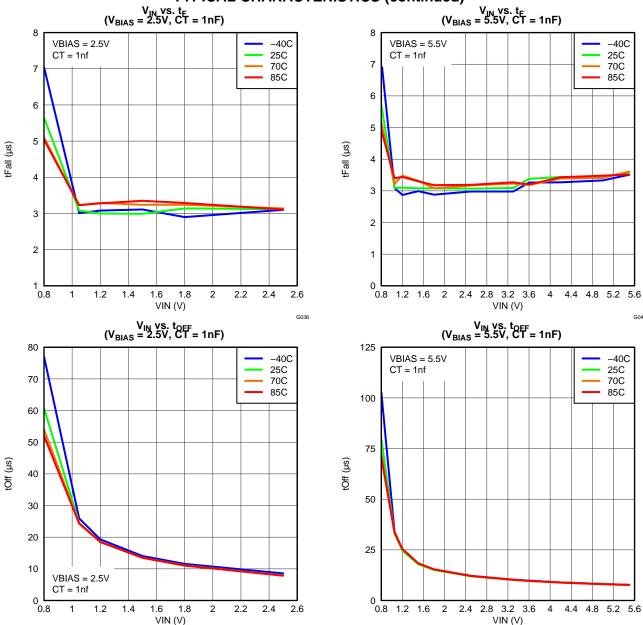
700

650

600 L 0.8



TYPICAL CHARACTERISTICS (continued)

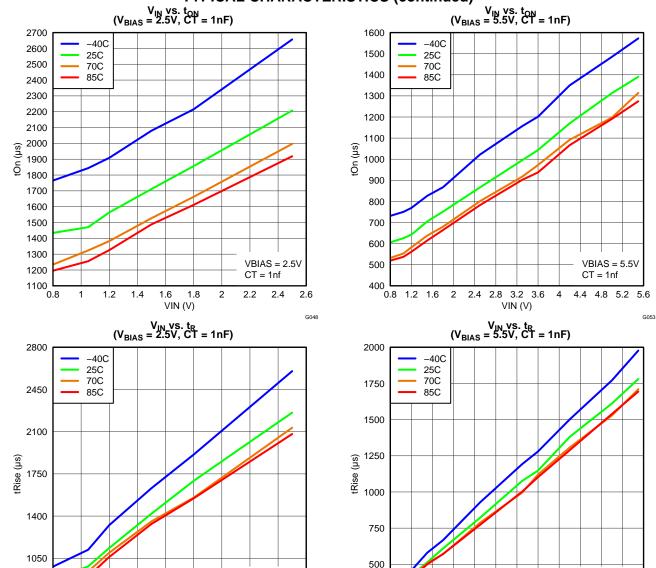


G047

G042



TYPICAL CHARACTERISTICS (continued)



VBIAS= 2.5V

2.4

2.6

G061

250

1.2 1.6

2

CT = 1nf

2.2

1.2

1.4

1.6 1.8

VIN (V)

2.4 2.8 3.2 3.6

VIN (V)

VBIAS = 5.5V

4.4 4.8 5.2 5.6

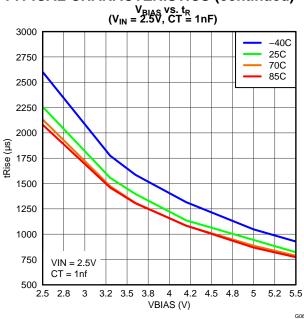
G059

CT = 1nf

700

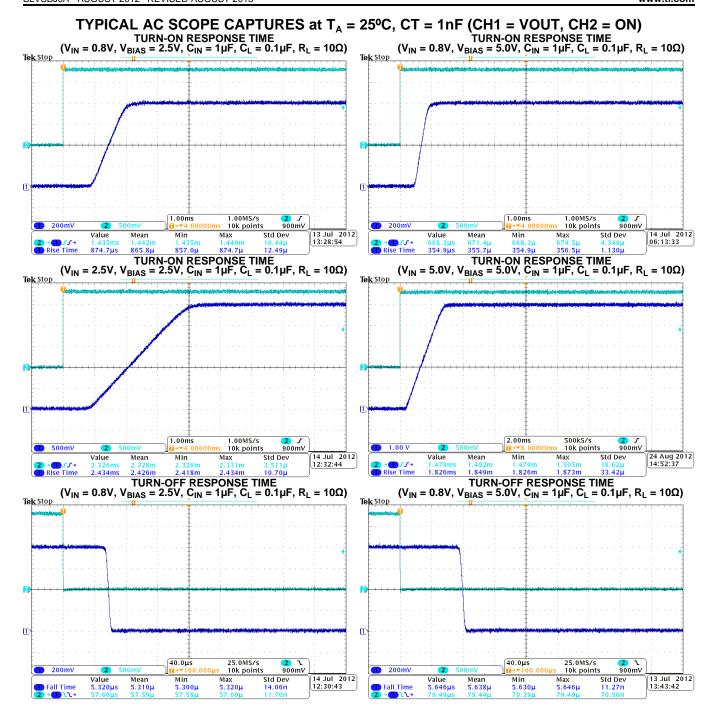


TYPICAL CHARACTERISTICS (continued)

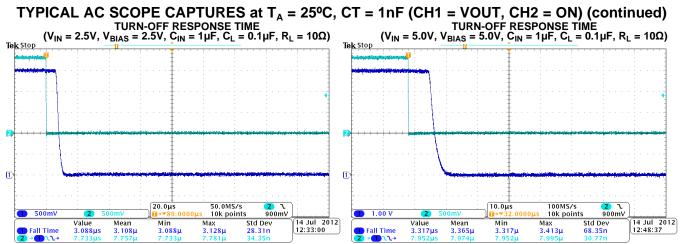


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APPLICATION INFORMATION

ON/OFF CONTROL

The ON pin controls the state of the switch. Asserting ON high enables the switch. ON is active high and has a low threshold, making it capable of interfacing with low-voltage signals. The ON pin is compatible with standard GPIO logic thresholds. It can be used with any microcontroller with 1.2V or higher GPIO voltage. This pin cannot be left floating and must be driven either high or low for proper functionality.

INPUT CAPACITOR (OPTIONAL)

To limit the voltage drop on the input supply caused by transient in-rush currents when the switch turns on into a discharged load capacitor or short-circuit, a capacitor needs to be placed between VIN and GND. A 1- μ F ceramic capacitor, C_{IN} , placed close to the pins, is usually sufficient. Higher values of C_{IN} can be used to further reduce the voltage drop during high current applications. When switching heavy loads, it is recommended to have an input capacitor about 10 times higher than the output capacitor to avoid excessive voltage drop.

OUTPUT CAPACITOR (OPTIONAL)

Due to the integrated body diode in the NMOS switch, a C_{IN} greater than C_L is highly recommended. A C_L greater than C_{IN} can cause V_{OUT} to exceed V_{IN} when the system supply is removed. This could result in current flow through the body diode from V_{OUT} to V_{IN} . A C_{IN} to C_L ratio of 10 to 1 is recommended for minimizing V_{IN} dip caused by inrush currents during startup, however a 10 to 1 ratio for capacitance is not required for proper functionality of the device. A ratio smaller than 10 to 1 (such as 1 to 1) could cause slightly more V_{IN} dip upon turn-on due to inrush currents. This can be mitigated by increasing the capacitance on the CT pin for a longer rise time (see below).

V_{IN} and V_{BIAS} VOLTAGE RANGE

For optimal R_{ON} performance, make sure $V_{IN} \le V_{BIAS}$. The device will still be functional if $V_{IN} > V_{BIAS}$ but it will exhibit R_{ON} greater than what is listed in the ELECTRICAL CHARACTERISTICS table. See Figure 3 for an example of a typical device. Notice the increasing R_{ON} as V_{IN} exceeds V_{BIAS} voltage. Be sure to never exceed the maximum voltage rating for V_{IN} and V_{BIAS} .

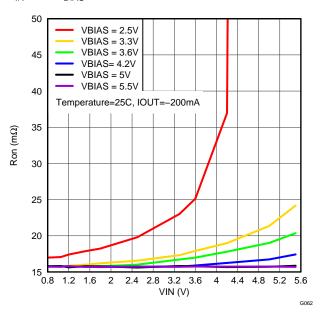


Figure 3. R_{ON} vs. V_{IN} ($V_{IN} > V_{BIAS}$)



ADJUSTABLE RISE TIME

A capacitor to GND on the CT pins sets the slew rate for each channel. The voltage on the CT pin can be as high as 12V. Therefore, the minimum voltage rating for the CT cap should be 25V for optimal performance. An approximate formula for the relationship between CT and slew rate is (the equation below accounts for 10% to 90% measurement on V_{OUT} and does **NOT** apply for CT = 0pF. Use table below to determine rise times for when CT = 0pF):

$$SR = 0.39 \times CT + 13.4$$
 (1)

Where,

 $SR = slew rate (in \mu s/V)$

CT = the capacitance value on the CT pin (in pF)

The units for the constant 13.4 is in μ s/V. The units for the constant 0.39 are in μ s/(V*pF).

Rise time can be calculated by multiplying the input voltage by the slew rate. The table below contains rise time values measured on a typical device. Rise times shown below are only valid for the power-up sequence where V_{IN} and V_{BIAS} are already in steady state condition, and the ON pin is asserted high.

CTx (pF)	RISE TIME (μ s) 10% - 90%, C_L = 0.1 μ F, C_{IN} = 1 μ F, R_L = 10 Ω TYPICAL VALUES at 25°C, 25V X7R 10% CERAMIC CAP									
	5V	3.3V	1.8V	1.5V	1.2V	1.05V	V8.0			
0	127	93	62	55	51	46	42			
220	475	314	188	162	141	125	103			
470	939	637	359	304	255	218	188			
1000	1869	1229	684	567	476	414	344			
2200	4020	2614	1469	1211	1024	876	681			
4700	8690	5746	3167	2703	2139	1877	1568			
10000	18360	12550	6849	5836	4782	4089	3449			



BOARD LAYOUT AND THERMAL CONSIDERATIONS

For best performance, all traces should be as short as possible. To be most effective, the input and output capacitors should be placed close to the device to minimize the effects that parasitic trace inductances may have on normal operation. Using wide traces for VIN, VOUT, and GND helps minimize the parasitic electrical effects along with minimizing the case to ambient thermal impedance.

The maximum IC junction temperature should be restricted to 125° C under normal operating conditions. To calculate the maximum allowable dissipation, $P_{D(max)}$ for a given output current and ambient temperature, use the following equation as a guideline:

$$\mathsf{P}_{\mathsf{D}(\mathsf{max})} = \frac{\mathsf{T}_{\mathsf{J}(\mathsf{max})} - \mathsf{T}_{\mathsf{A}}}{\Theta_{\mathsf{JA}}} \tag{2}$$

Where:

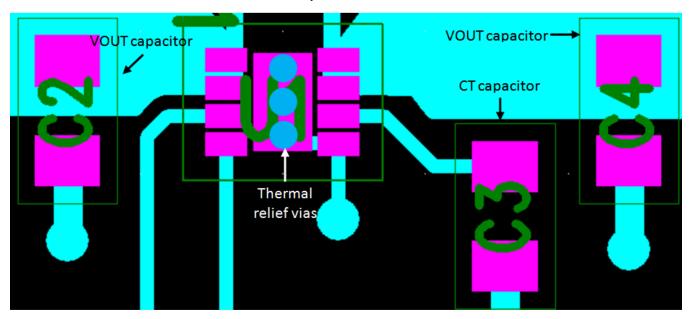
 $P_{D(max)}$ = maximum allowable power dissipation

T_{J(max)} = maximum allowable junction temperature (125°C for the TPS22965)

 T_A = ambient temperature of the device

 Θ_{JA} = junction to air thermal impedance. See Thermal Information section. This parameter is highly dependent upon board layout.

The figure below shows an example of a layout. Notice the thermal vias located under the exposed thermal pad of the device. This allows for thermal diffusion away from the device.



Submit Documentation Feedback



REVISION HISTORY

Cr	nanges from Original (August 2012) to Revision A	Page
•	Removed Ordering Information table.	2
•	Updated V_{ON} MAX value to fix typo that restricted operating range. Changed MAX value from " V_{IN} " to "5.5" to align with rest of document.	3



PACKAGE OPTION ADDENDUM

12-Aug-2013

PACKAGING INFORMATION

www.ti.com

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
TPS22965DSGR	ACTIVE	WSON	DSG	8	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	ZSA0	Samples
TPS22965DSGT	ACTIVE	WSON	DSG	8	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	ZSA0	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

- (3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

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PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TPS22965DSGR	WSON	DSG	8	3000	180.0	8.4	2.3	2.3	1.15	4.0	8.0	Q2
TPS22965DSGT	WSON	DSG	8	250	180.0	8.4	2.3	2.3	1.15	4.0	8.0	Q2

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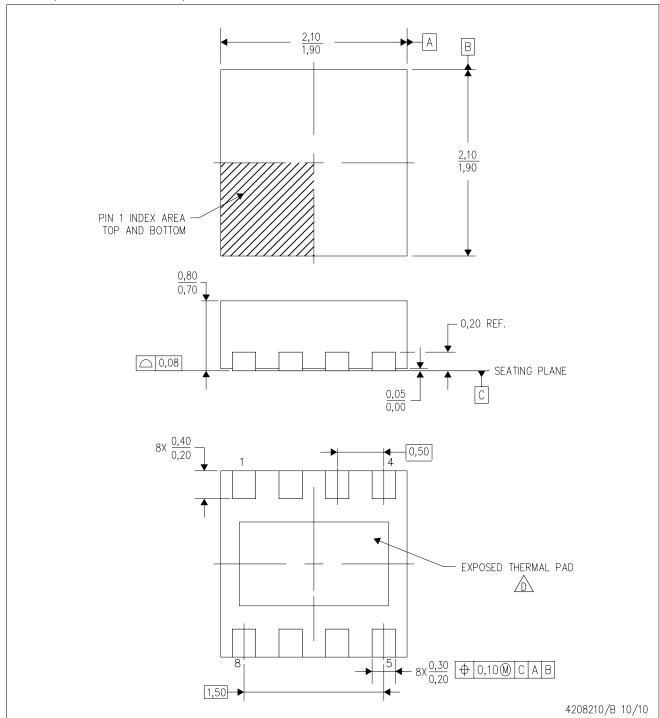


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins SPQ		Length (mm)	Width (mm)	Height (mm)	
TPS22965DSGR	WSON	DSG	8	3000	210.0	185.0	35.0	
TPS22965DSGT	WSON	DSG	8	250	210.0	185.0	35.0	

DSG (S-PWSON-N8)

PLASTIC SMALL OUTLINE NO-LEAD



NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.

- This drawing is subject to change without notice.
- Quad Flatpack, No-Leads (QFN) package configuration.
- The package thermal pad must be soldered to the board for thermal and mechanical performance.

See the Product Data Sheet for details regarding the exposed thermal pad dimensions.

E. Falls within JEDEC MO-229.



DSG (S-PWSON-N8)

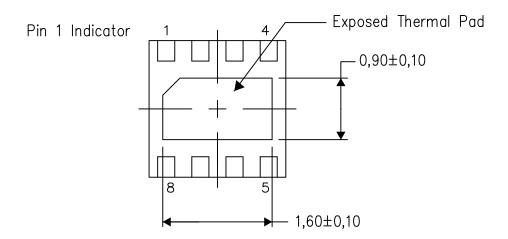
PLASTIC SMALL OUTLINE NO-LEAD

THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No—Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



Bottom View

Exposed Thermal Pad Dimensions

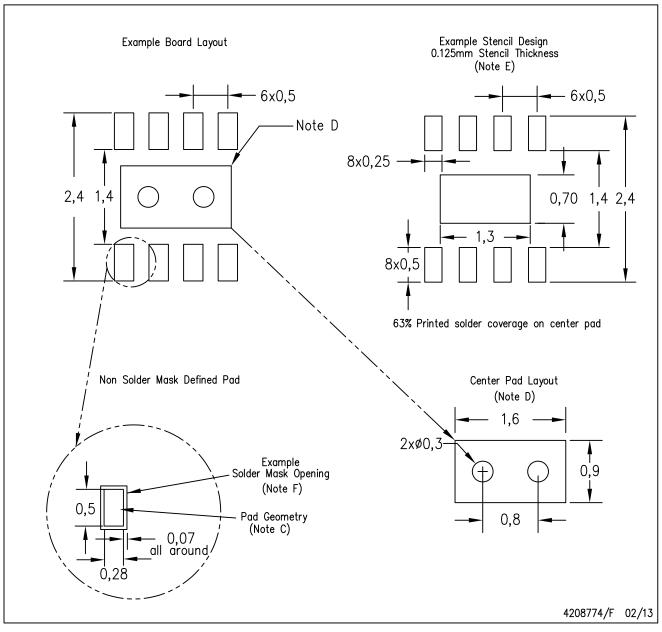
4208347/G 08/13

NOTE: All linear dimensions are in millimeters



DSG (S-PWSON-N8)

PLASTIC SMALL OUTLINE NO-LEAD



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com http://www.ti.com.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
- F. Customers should contact their board fabrication site for solder mask tolerances.



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